

International IR Rectifier

PD - 96350

IRF4104GPbF

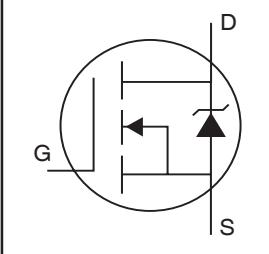
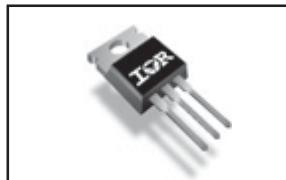
Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free
- Halogen-Free

Description

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.

HEXFET® Power MOSFET

	$V_{DSS} = 40V$ $R_{DS(on)} = 5.5m\Omega$ $I_D = 75A$
	TO-220AB IRF4104GPbF

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)	120	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	84	
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Package limited)	75	
I_{DM}	Pulsed Drain Current ^①	470	
$P_D @ T_C = 25^\circ C$	Power Dissipation	140	W
	Linear Derating Factor	0.95	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS} (Thermally limited)	Single Pulse Avalanche Energy ^②	120	mJ
E_{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ^③	220	
I_{AR}	Avalanche Current ^④	See Fig.12a, 12b, 15, 16	A
E_{AR}	Repetitive Avalanche Energy ^⑤		mJ
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds		
	Mounting Torque, 6-32 or M3 screw ^⑦	300 (1.6mm from case) 10 lbf•in (1.1N•m)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{θJC}$	Junction-to-Case	—	1.05	°C/W
$R_{θCS}$	Case-to-Sink, Flat Greased Surface ^⑧	0.50	—	
$R_{θJA}$	Junction-to-Ambient ^⑨	—	62	

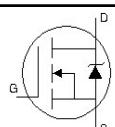
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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	40	—	—	V	$V_{\text{GS}} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.032	—	V°C	Reference to 25°C , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	4.3	5.5	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$, $I_D = 75\text{A}$ ③
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}} = V_{\text{GS}}$, $I_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	63	—	—	V	$V_{\text{DS}} = 10\text{V}$, $I_D = 75\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	$V_{\text{DS}} = 40\text{V}$, $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 40\text{V}$, $V_{\text{GS}} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	68	100		$I_D = 75\text{A}$
Q_{gs}	Gate-to-Source Charge	—	21	—	nC	$V_{\text{DS}} = 32\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	27	—		$V_{\text{GS}} = 10\text{V}$ ③
$t_{\text{d(on)}}$	Turn-On Delay Time	—	16	—		
t_r	Rise Time	—	130	—		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	38	—	ns	$V_{\text{DD}} = 20\text{V}$
t_f	Fall Time	—	77	—		$I_D = 75\text{A}$
R_G	Series Gate Resistor	—	6.8	—		$R_G = 6.8 \Omega$
L_D	Internal Drain Inductance	—	4.5	—		
L_S	Internal Source Inductance	—	7.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
C_{iss}	Input Capacitance	—	3000	—		$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	660	—		$V_{\text{DS}} = 25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	380	—	pF	$f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	2160	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 1.0\text{V}$, $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	560	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 32\text{V}$, $f = 1.0\text{MHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance	—	850	—		$V_{\text{GS}} = 0\text{V}$, $V_{\text{DS}} = 0\text{V}$ to 32V ④

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	75	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	470		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_S = 75\text{A}$, $V_{\text{GS}} = 0\text{V}$ ③
t_{rr}	Reverse Recovery Time	—	23	35	ns	$T_J = 25^\circ\text{C}$, $I_F = 75\text{A}$, $V_{\text{DD}} = 20\text{V}$
Q_{rr}	Reverse Recovery Charge	—	6.8	10	nC	$\text{di/dt} = 100\text{A}/\mu\text{s}$ ③
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

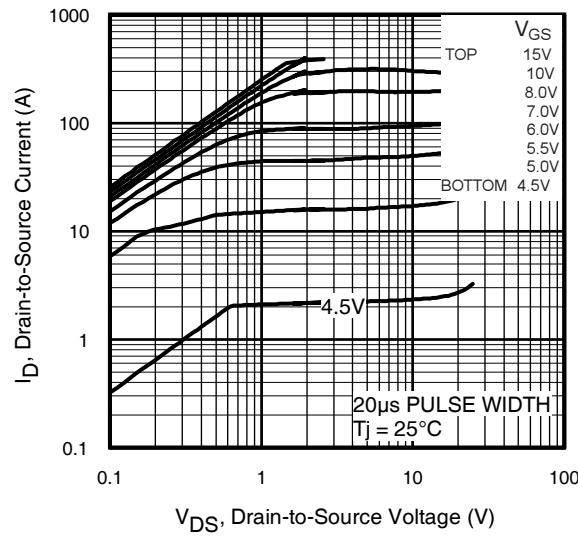


Fig 1. Typical Output Characteristics

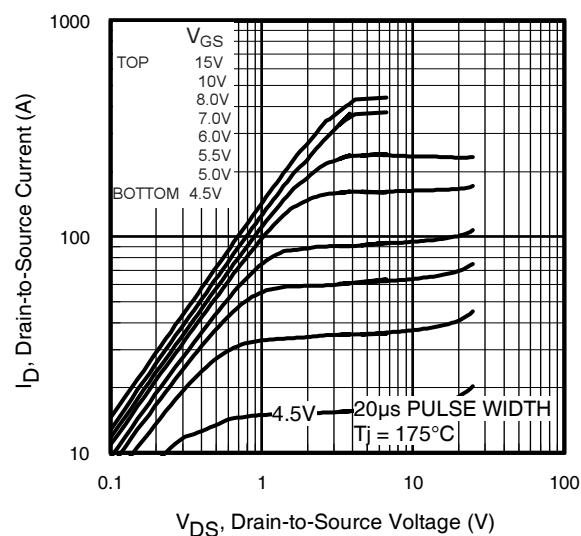


Fig 2. Typical Output Characteristics

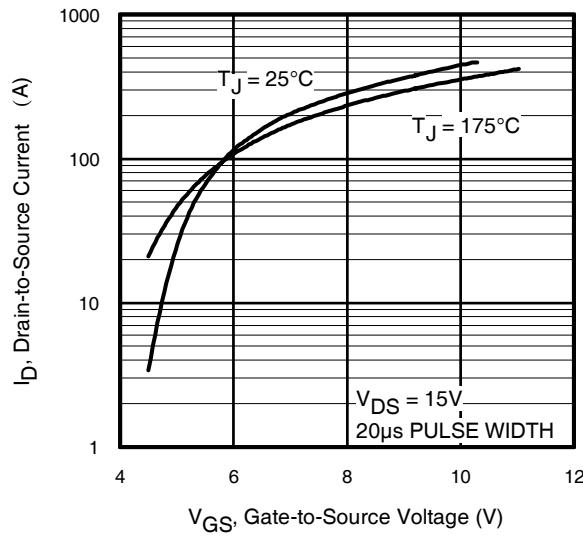


Fig 3. Typical Transfer Characteristics

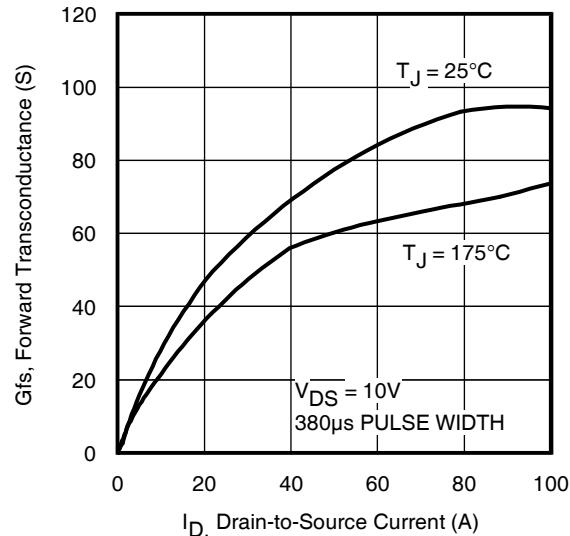


Fig 4. Typical Forward Transconductance Vs. Drain Current

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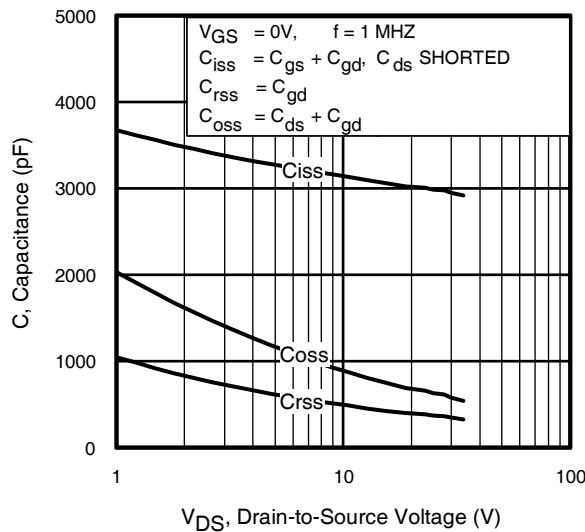


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

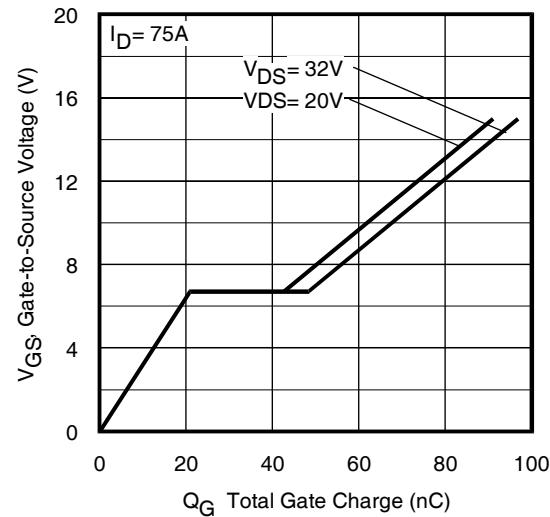


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

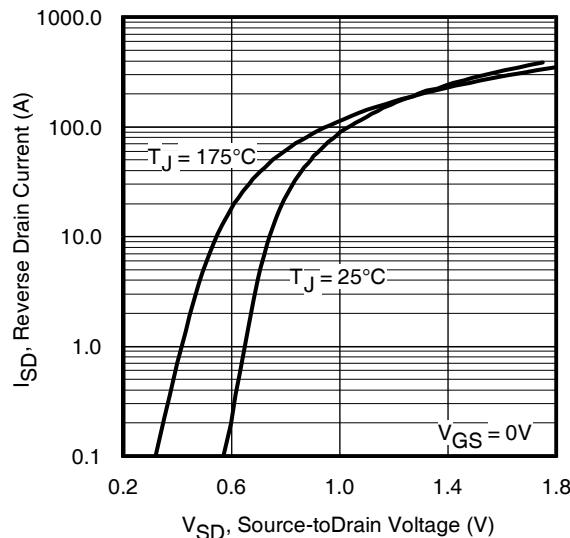


Fig 7. Typical Source-Drain Diode
Forward Voltage

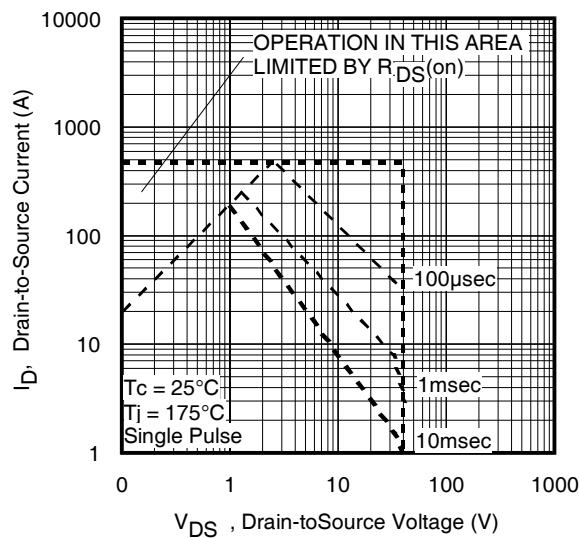


Fig 8. Maximum Safe Operating Area

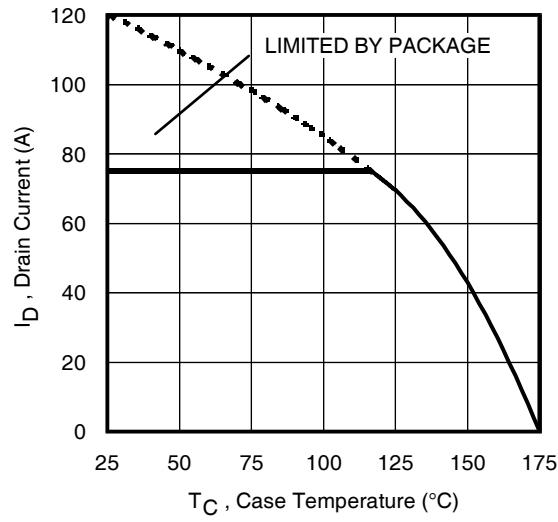


Fig 9. Maximum Drain Current Vs.
Case Temperature

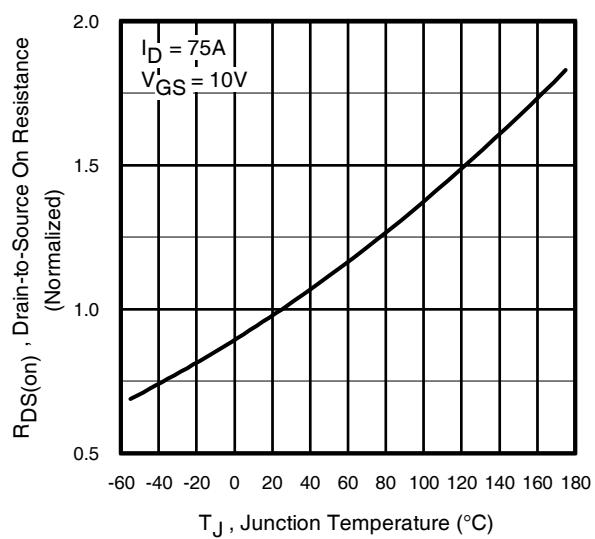


Fig 10. Normalized On-Resistance
Vs. Temperature

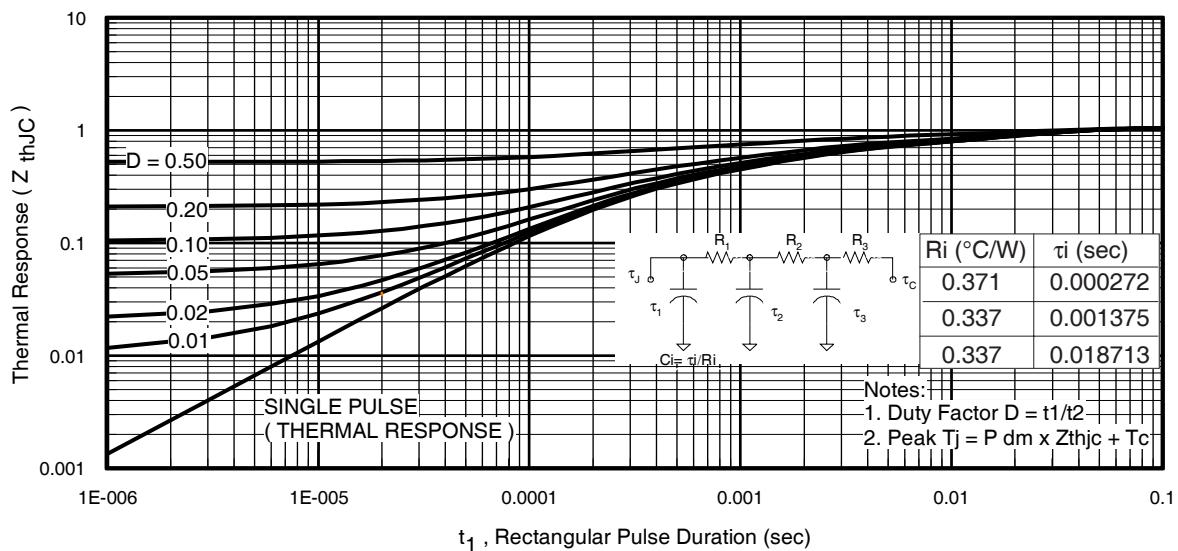


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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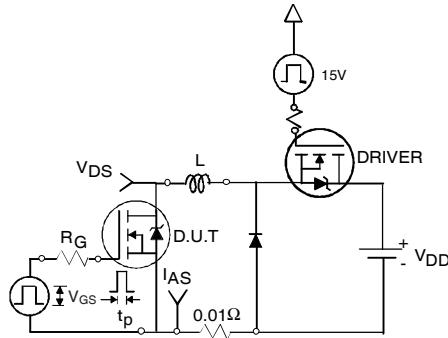


Fig 12a. Unclamped Inductive Test Circuit

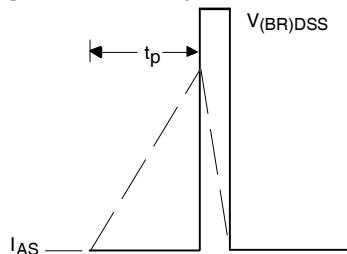


Fig 12b. Unclamped Inductive Waveforms

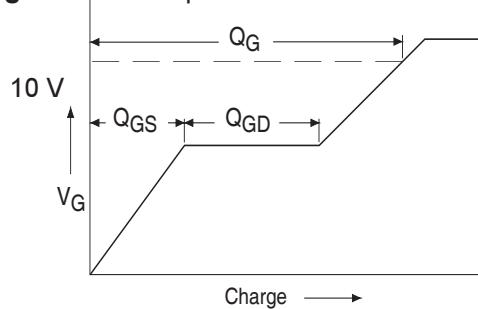


Fig 13a. Basic Gate Charge Waveform

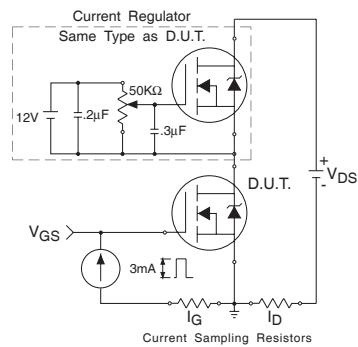


Fig 13b. Gate Charge Test Circuit

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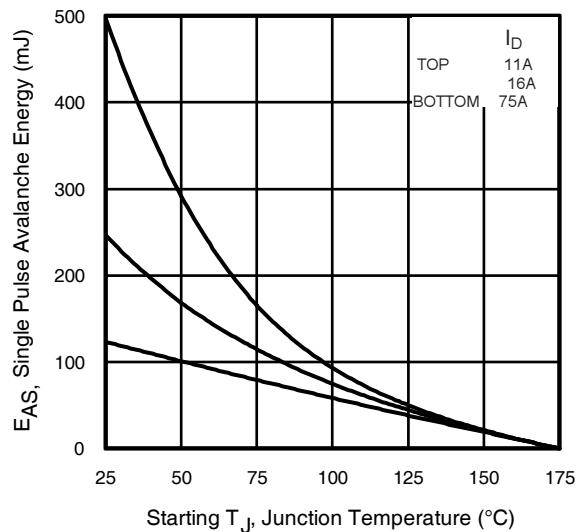


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

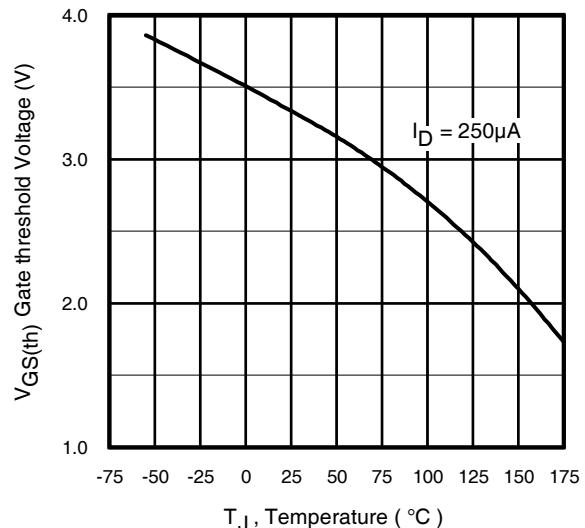


Fig 14. Threshold Voltage Vs. Temperature

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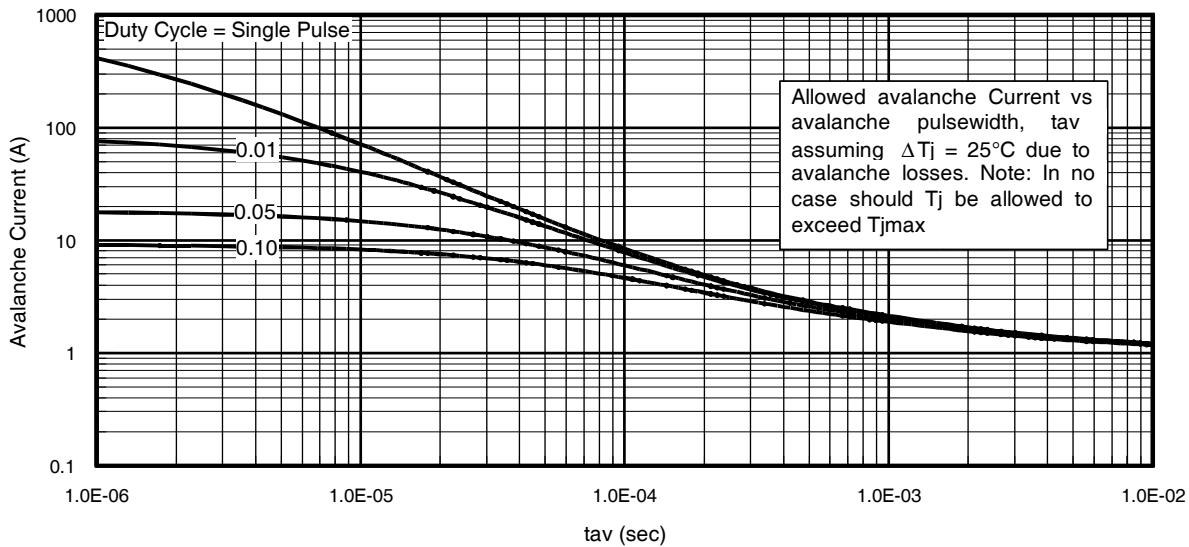


Fig 15. Typical Avalanche Current Vs.Pulsewidth

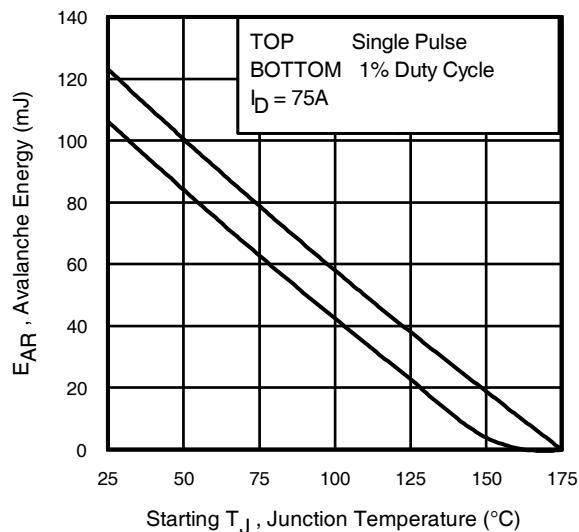


Fig 16. Maximum Avalanche Energy Vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:
 (For further info, see AN-1005 at www.irf.com)**

1. Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
 4. $P_{D(ave)}$ = Average power dissipation per single avalanche pulse.
 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
 6. I_{av} = Allowable avalanche current.
 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
- t_{av} = Average time in avalanche.
 D = Duty cycle in avalanche = $t_{av} \cdot f$
 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

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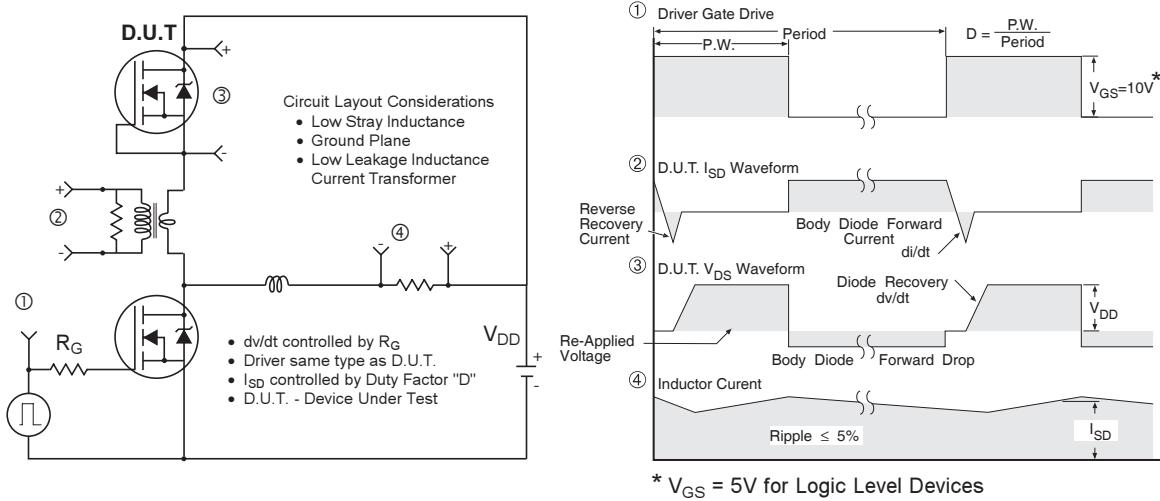


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

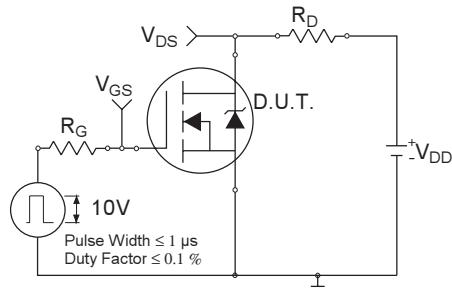


Fig 18a. Switching Time Test Circuit

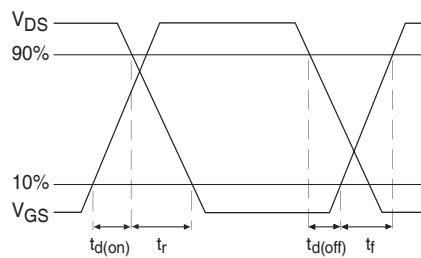


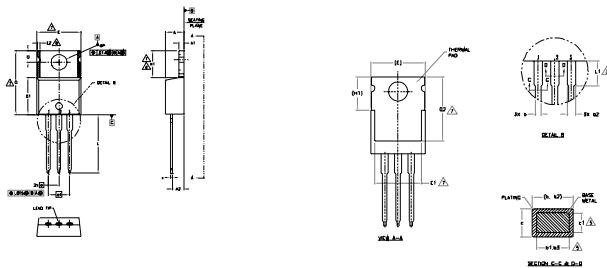
Fig 18b. Switching Time Waveforms

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TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1 - DIMENSIONING AND TOLERANCING PER ASME Y14.5M - 1994.
- 2 - DIMENSIONS ARE IN MILLIMETERS.
- 3 - LEAD DIMENSION AND FLASH UNCONTROLLED IN L1.
- 4 - DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH IS UNCONTROLLED. DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5 - DIMENSION A1 & A2 APPLY TO BASE METAL ONLY.
- 6 - CROWN HEIGHT IS UNCONTROLLED.
- 7 - THERMAL PADS CONTAIN OPTIONAL MINIMUM DIMENSIONS C1, D2 & E1.
- 8 - DIMENSION E2 X H DEFINE A ZONE WHERE STAMPING AND SINGULATION PRECAUTIONS ARE ALLOWED.
- 9 - DUE TO PLASTIC EXPANSION DIMENSIONS A2 (mm) AND D2 (mm) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

SYMBOL	DIMENSIONS			NOTES
	UNITS	IN MILLIMETERS	IN INCHES	
A	1.56	.485	.140	100
A1	0.51	1.40	.020	.055
A2	2.05	2.92	.085	.115
b	0.56	1.01	.016	.040
b1	0.40	.97	.035	.035
b2	1.14	1.78	.045	.070
b3	1.14	1.73	.045	.068
c	0.36	.681	.014	.024
d	0.56	1.40	.022	5
D	14.72	16.51	.560	.650
D1	8.35	9.02	.332	.355
D2	11.64	12.68	.460	.507
E	9.65	10.47	.380	.420
E1	6.86	8.81	.270	.350
E2	0.76	1.00	.030	8
e	7.74	8.56	.300	.350
e1	1.05	1.25	.040	.050
H	0.94	6.96	.230	.270
L	12.70	14.73	.500	.560
L1	3.56	4.06	.140	.160
P	354	4.08	.139	.161
D	2.54	3.42	.100	.135

LEAD TERMINALS

- 1 - GATE
- 2 - DRAIN
- 3 - SOURCE

MARKING

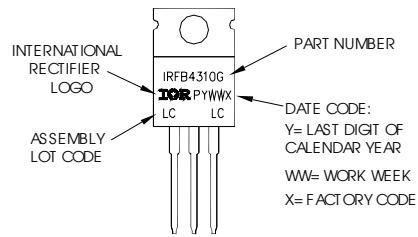
- 1 - GATE
- 2 - DRAIN
- 3 - SOURCE
- 4 - ANODE
- 5 - CATHODE

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRFB4310GPBF

Note: "G" suffix in part number indicates "Halogen-Free"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB package is not recommended for Surface Mount Application

Notes:

1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/datasheets/data/auirf4104.pdf>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Notes:

- ① Repetitive rating: pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by T_{Jmax} , starting $T_J = 25^\circ\text{C}$, $L = 0.04\text{mH}$ $R_G = 25\Omega$, $I_{AS} = 75\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value.
- ③ Pulse width $\leq 1.0\text{ms}$; duty cycle $\leq 2\%$.
- ④ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑤ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population. 100% tested to this value in production.
- ⑦ This is only applied to TO-220AB package.

Data and specifications subject to change without notice.
This product has been designed and qualified for the Industrial market.
Qualification Standards can be found on IR's Web site.

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